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Pages 1 to 26

CRYSTAL UNITS IN METAL HOLDER, BASED ON TYPE T2111,

FREQUENCY RANGE 0.8 - 50MHZ

ESA/SCC Detail Specification No. 3501/003



space components coordination group

l	_	Appr	oved by
Issue/Rev.	Date	SCCG Chairman	ESA Director Genera or his Deputy
Issue 3	February 1998	Sa mit	Hoom
	-		200



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DOCUMENTATION CHANGE NOTICE

Rev.	Rev.	CHANGE	Approved DCR No.
Letter	Date	Reference Item	
		This Issue supersedes Issue 2 and incorporates all modifications 'A', 'B', 'C', 'D' and 'E' to Issue 2 and the char following DCRs:- Cover Page DCN Table 1(a) : Storage Temperature Rai Table 1(b) : No. 4, in Remarks, Note : No. 5, in Remarks, Note : New Note 3 added : Existing Note 3 renumber Table 1(c) : Item 20 deleted : Existing Item 21 renumber Figure 2 : Drawing and Table amen : Vibration Axes and Notes Para. 4.3.3 : Second sentence deleted Para. 4.5.5 : Deleted in toto Para. 4.5.6 : Renumbered to "4.5.5" Para. 4.6.1 : Second sentence rewritted Para. 4.6.3 : Deleted in toto Para. 4.6.4 : Renumbered to "4.6.3" Table 6 : Table reformatted Ind. Tables 1(a) : Item 20 deleted	None None None nge column deleted number amended number amended 221336 221336 221336 221336 221336 221336 221336 221336 221336 221336 221336 221341 new text added 221341 221465 221465



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APPENDICES (Applicable to specific Manufacturers only)

None.



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1. **GENERAL**

1.1 SCOPE

This specification details the values, physical and electrical characteristics, test and inspection data for Crystal Units in Metal Holder, based on Type T2111, Frequency Range 0.8 - 50MHz.

It shall be read in conjunction with ESA/SCC Generic Specification No. 3501, the requirements for which are supplemented herein.

1.2 TYPE VARIANTS

A list of the type variants of the crystal units specified herein, which are also covered by this specification, is given in "Table 1(a) - Type Variant Summary".

For each type variant, the full electrical and physical characteristics are given in individual Tables 1(a) - "Type Variant Detailed Information" at the end of this specification.

The contents of the individual Tables 1(a) shall be as shown in Table 1(c) and the characteristics therein listed shall relate to the design parameters of the individual crystal units, optimised for the intended application.

The specific characteristics shall be negotiated between the Manufacturer and the Orderer. The Manufacturer shall then apply to the ESA/SCC Secretariat for a type variant number for each individual crystal unit concerned, by sending a finalised Table 1(a) which shall also be copied to the Qualifying Space Agency (QSA).

1.3 MAXIMUM RATINGS

The maximum ratings, which shall not be exceeded at any time during use or storage, applicable to the crystal units specified herein, are as scheduled in Table 1(b).

1.4 PHYSICAL DIMENSIONS

The physical dimensions of the crystal units specified herein are shown in Figure 2.

1.5 FUNCTIONAL DIAGRAM

The functional diagram showing lead identification of the crystal units specified herein is shown in Figure 3.



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TABLE 1(a) - TYPE VARIANT SUMMARY

Variant	Resonance Frequency	Load Capacitance	Reference Temp.	Operating Temp. Range	Intended Applicat.	Lead L (Dim.	
	(MHz)	(C _L pF)	(T _o ℃)	(T _{op} °C)	пррисат.	Min.	Max.
01	2.0736	30	+ 25	-55 to +105	-	25.0	26.0
02	2.0	30	+ 25	-20 to +60	-	25.0	26.0
03	2.4576	20	+ 25	-40 to +70	-	25.0	26.0
04	2.304	30	+ 25	-40 to +70	-	25.0	26.0
25	20.125984	27.5	+ 56	+53 to +58		25.0	26.0
60	1.536	30	+ 25	0 to +80	-	25.0	26.0

NOTES

^{1.} Full electrical and physical characteristics are given in the individual Tables 1(a) at the end of this specification.



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TABLE 1(b) - MAXIMUM RATINGS

No.	Characteristic	Symbol	Values	Unit	Remarks
1	Nominal Frequency Range	f	0.8 to 50	MHz	Note 1
2	Drive Level Range	Р	0.1 to 2.0	mW	
3	Operating Temperature Range	T _{op}	-	°C	Note 2
4	Storage Temperature Range	T _{stg}	-65 to +125	°C	Note 3
5	Soldering Temperature	T _{sol}	+260	°C	Note 4

NOTES

1.	Fundamental and Overtone Order	Approx. Frequency Range (MHz)
	Fundamental	0.8 to 10
	3	10 to 30
	5	15 to 50

- 2. See Table 1(a).
- 3. The duration at maximum storage temperature shall not exceed 16 hours.
- 4. Duration 10 seconds maximum at a distance of not less than 3.0mm from the device body and the same lead shall not be resoldered until 3 minutes have elapsed.



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TABLE 1(c) - FORMAT FOR INDIVIDUAL TABLES 1(a) TABLE 1(a) - TYPE VARIANT DETAILED INFORMATION

TYPE VARIANT NO.

			Lin	nits		
No.	Characteristic	Symbol	Min.	Max	Unit	Remarks
1	Resonance Frequency	f _r or f _L			MHz	Note 1
2	Reference Temperature	T _o			°C	Note 2
3	Overtone Order	-				
4	Load Capacitance	C _L			рF	Note 3
5	Rated Drive Level	Po			mW	Note 4
6	Frequency Adjustment Tolerance	<u>∆ f</u> f			10 ⁻⁶	At To °C Note 5
7	Resonance Resistance	R _r or R _L			Ω	At To °C Note 6
8	Frequency Variation with Temperature over T _{op}	$\frac{\Delta f}{f}$			10 ⁻⁹	From frequency measured at T _o °C Note 7
9	Resistance Variation with Temperature over Top	<u>∆ R</u> R			%	From resistance measured at T _o °C Note 7
10	Operating Temperature Range	T _{op}			°C	
11	Frequency variation with Drive Level	<u>∆ f</u> f			10-6	From $P_{S1} = mW$ to $P_{S2} = mW$ Note 8
12	Resistance variation with Drive Level	<u>∆ R</u> R			%	From $P_{S1} = mW$ to $P_{S2} = mW$ Note 8
13	Motional Inductance	L ₁			mH	Notes 9 and 10
14	Motional Capacitance	C ₁			fF	Note 9
15	Static Capacitance	Co			pF	Note 9
16	Q Factor	Q			-	Notes 9 and 11
17	Ratio of unwanted: Response Resistance to Resonance Resistance or Response Impedance to Resonance Resistance	R _p /R or IZ _p I/R				In the frequency range: f - kHz to f + kHz
18	Ageing	<u>Δ f</u> f			10-6	Note 13
19	Terminal length	С			mm	Note 14
20	Intended Application					Note 16

NOTES: See Pages 9 and 10.



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NOTES TO TABLE 1(c)

- 1. (a) If C_L is not specified, Symbol and measurement shall be f_r.
 - (b) If C_L is specified, Symbol and measurement shall be f_L.

2. Reference Temperature To

- (a) For a crystal unit functioning in a non-controlled temperature environment, the reference temperature is normally +25 ±2 °C.
- (b) For a crystal unit functioning in a controlled temperature environment, the reference temperature shall normally be the mid-point of the temperature range of the controlled environment.

3. Load Capacitance CL

- (a) When a crystal unit must function at its series resonance frequency, C_L shall be infinite.
- (b) When a crystal must function with a load capacitance, the C_L value shall be specified. The standard values of load capacitance are as follows:
- Fundamental Frequency Operation: 20pF, 30pF, 50pF and 100pF.
- Overtone Operation: 8pF, 12pF, 15pF, 20pF and 30pF.

N.B

The tolerance on the load capacitance shall be that value which results in a frequency change not exceeding 10% of the frequency tolerance at To or 1% of the nominal load capacitance, whichever is smaller.

Rated Drive Level Po

The rated drive level shall be selected from the standard drive levels specified below:

- Preferred values: 2mW, 1mW, 0.5mW, 0.2mW, 0.1mW, 0.05mW, 0.02mW, 0.01mW, 0.001mW or 0.0001mW at ± 20 %.
- Non-preferred values: 10mW, 5mW and 4mW all at $\pm 20\%$.

5. Frequency Adjustment Tolerance

- (a) When a crystal must function at its series resonance frequency, the standard value of the adjustment tolerance shall be ±10 x 10-6.
- (b) When a crystal has to function with a load capacitance, the standard value of the adjustment tolerance shall also be $\pm 10 \times 10^{-6}$. However, if the load capacitance is adjustable, it is preferable to specify that the nominal frequency be obtained with a load capacitance value between the minimum and maximum value when the crystal is functioning in its fundamental mode.

6. Resonance Resistance

- (a) Generally, the maximum value only is specified.
- (b) R_L may be calculated by R_L = R_r $\left(1 + \frac{C_0}{C_L}\right)^2$

7. Frequency and Resistance Variation with Temperature

These values shall be specified such that they are consistent with the operating temperature range.

8. Frequency and Resistance Variation with Drive Level

These limits and the Drive Level range (PS1 to PS2) shall be specified for very special crystals only (i.e. crystals used in very high stability oscillators).



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NOTES TO TABLE 1(c) (Continued)

9. Electrical Values

The electrical values shall be specified only when required for the correct functioning of the equipment in which the crystal is used.

10. Motional Inductance L₁

Because the inductance value may be restricted by other chosen parameters, the Manufacturer shall propose the value of L_1 in accordance with the Customer's requirements.

11. 'Q' Factor

If 'R' and 'L' have been already specified, it will not be necessary to specify the minimum value of the 'Q' factor.

The maximum value of the 'Q' factor is never specified.

12. Ratio of Unwanted Response Resistance to Resonance Resistance

The standard minimum value is 2, but it is possible to obtain higher values.

The frequency range within which the minimum value of the ratio is required shall also be specified.

13. Ageing

Specify limits under appropriate column and ageing period under "Remarks".

14. Terminal Lengths

To be specified if different from Figure 2 dimensions. If dimensions are as per Figure 2 then "Figure 2" to be entered in the Limits column.

15. Not applicable Items

For all items where limits are not specified, "Not applicable" shall be entered in the Limits column.

16. Intended Application

For definitions of the selected symbols to be added, see ESA/SCC Generic Specification No. 3501, Para. 3.



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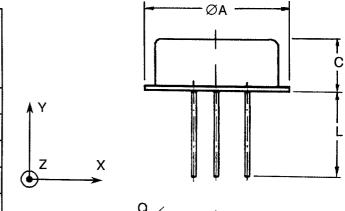
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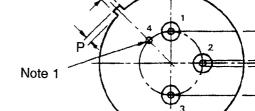
FIGURE 1 - PARAMETER DERATING INFORMATION

Not applicable.

FIGURE 2 - PHYSICAL DIMENSIONS

Symbol	Millim	etres	Damada
Symbol	Min.	Max.	Remarks
ØA	-	22.00	
С	-	11.60	
Н	9.29	9.77	Pitch 9.52mm
ØK	0.40	0.48	
L	12.70	-	
Р	-	0.90	Note 2
Q	-	0.95	Note 2

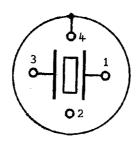




NOTES

- 1. Lead No. 4 is grounded to case.
- 2. The tag's position or presence is optional.

FIGURE 3 - FUNCTIONAL DIAGRAM



(Bottom View)

NOTES

- 1. Crystal connections 1 and 3.
- 2. Terminal 4 connected to Case.
- 3. Terminal 2 not connected.



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2. APPLICABLE DOCUMENTS

The following documents form part of this specification and shall be read in conjunction with it:-

(a) ESA/SCC Generic Specification No. 3501 for Quartz Crystal Units.

3. TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESA/SCC Basic Specification No. 21300 shall apply. In addition, the following symbols are used:-

Resonance Frequency $= f_r$ Load Resonance Frequency $= f_L$ Reference Temperature $= T_o$ Resonance Resistance $= R_r$ Load Resonance Resistance $= R_L$ Rated Drive Level = Po Static Capacitance $= C_o$ Load Capacitance = C_L Motional Capacitance = C₁ Motional Inductance $= L_1$ Response Resistance $= R_P$ Response Impedance $= |Z_{P}|$ Insulation Resistance = Ri

4. **REQUIREMENTS**

4.1 GENERAL

The complete requirements for procurement of the crystal units specified herein shall be as stated in this specification and ESA/SCC Generic Specification No. 3501 for Quartz Crystal Units. Deviations from the Generic Specification applicable to this specification only, are detailed in Para. 4.2.

Deviations from the applicable Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESA/SCC requirements and do not affect the components' reliability, are listed in the appendices attached to this specification.

4.2 <u>DEVIATIONS FROM GENERIC SPECIFICATION</u>

4.2.1 <u>Deviations from Special In-process Controls</u>

None.

4.2.2 <u>Deviations from Final Production Tests (Chart II)</u>

None

4.2.3 <u>Deviations from Burn-in Tests (Chart III)</u>

None.

4.2.4 <u>Deviations from Qualification Tests</u> (Chart IV)

None.

4.2.5 <u>Deviations from Lot Acceptance Tests</u> (Chart V)

None.



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4.3 <u>MECHANICAL REQUIREMENTS</u>

4.3.1 <u>Dimension Check</u>

The dimensions of the crystal units specified herein shall be checked. They shall conform to those shown in Figure 2.

4.3.2 Weight

The maximum weight of the crystal units specified herein shall be 7.0 grammes.

4.3.3 Robustness of Terminations

The requirements for robustness of termination testing are specified in Section 9 of ESA/SCC Generic Specification No. 3501.

4.4 MATERIALS AND FINISHES

The materials and finishes shall be as specified herein. Where a definite material is not specified, a material which will enable the crystal units specified herein to meet the performance requirements of this specification shall be used. Acceptance or approval of any constituent material does not guarantee acceptance of the finished product.

4.4.1 Case

4.4.1.1 Cap

Copper, nickel plated and gold plated.

4.4.1.2 Base

Kovar, nickel plated and gold plated.

4.4.2 Lead Material and Finish

The lead material shall be Type 'D' with Type '2' finish in accordance with the requirements of ESA/SCC Basic Specification No. 23500.

4.5 MARKING

4.5.1 General

The marking of all components delivered to this specification shall be in accordance with the requirements of ESA/SCC Basic Specification No. 21700 and the following paragraphs. When the component is too small to accommodate all of the marking specified, as much as space permits shall be marked and the marking information, in full, shall accompany the component in its primary package.

The information to be marked and the order of precendence, shall be as follows:-

- (a) The SCC Component Number.
- (b) Characteristics.
- (c) Traceability Information.

4.5.2 The SCC Component Number

Each component shall bear the SCC Component Number, which shall be constituted and marked as follows:-

Detail Specification Number	T T T
Type Variant, (see Table 1(a))	
Testing Level (B or C, as applicable)	



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4.5.3 Characteristics

The resonance frequency of the crystal units shall be clearly specified in MHz. Where necessary, it shall be specified to 6 decimal places.

4.5.4 Traceability Information

Each component shall be marked in respect of traceability information in accordance with the requirements of ESA/SCC Basic Specification No. 21700.

4.5.5 Manufacturer's Name, Symbol or Code

The Manufacturer's marking shall be in accordance with the requirements of ESA/SCC Basic Specification No. 21700.

4.6 <u>ELECTRICAL MEASUREMENTS</u>

4.6.1 <u>Electrical Measurements at Reference Temperature</u>

The parameters to be measured in respect of electrical characteristics are scheduled in Table 2. The measurements shall be performed at the temperatures specified in the individual Tables 1(a), Item 2.

4.6.2 <u>Electrical Measurements at High and Low Temperatures</u>

The parameters to be measured at high and low temperatures are scheduled in Table 3. These measurements shall only be performed if values are specified in Table 1(a) Items 8 and/or 9.

4.6.3 <u>Circuits for Electrical Measurements (Figure 4)</u>

Not applicable.

4.7 BURN-IN TESTS

4.7.1 Parameter Drift Values

The parameter drift values applicable to burn-in are specified in Table 4 of this specification. Unless otherwise stated, measurements shall be performed at $T_{amb} = T_0 \pm 2$ °C. The parameter drift values (Delta) applicable to the scheduled parameters shall not be exceeded. In addition to these drift value requirements for a given parameter, the appropriate limit value specified in Table 2 shall not be exceeded.

4.7.2 Conditions for Burn-in

The requirements for burn-in are specified in Section 7 of ESA/SCC Generic Specification No. 3501. The conditions for burn-in shall be as specified in Table 5 of this specification.

4.7.3 <u>Electrical Circuits for Burn-in (Figure 5)</u>

Not applicable.

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TABLE 2 - ELECTRICAL MEASUREMENTS AT REFERENCE TEMPERATURE

		T		T	
No.	Characteristics	Symbol	ESA/SCC 3501 Test Method	Limits	Unit
1	Resonance frequency at reference temperature and rated drive level - with C _O - with C _L	f _r (T _o , P _o) f _L (T _o , P _o)	Para. 9.2.1.1	Table 1(a), Item 1 ± Item 6	MHz
2	Resonance resistance at reference temperature and rated drive level - with C _O - with C _L	R _r (T _o , P _o) R _L (T _o , P _o)	Para. 9.2.1.1	Table 1(a), Item 7	Ω
3	Frequency variation with Drive Level	$\frac{\Delta f}{f}$ (T _o , Δ P)	Para. 9.2.1.1	Table 1(a), Item 11	10-6
4	Resistance variation with Drive Level	$\frac{\Delta R}{R}$ (T ₀ , ΔP)	Para. 9.2.1.1	Table 1(a), Item 12	%
5	Motional Inductance	L ₁	Para. 9.2.1.3	Table 1(a), Item 13	mH
6	Static Capacitance	Co	Para. 9.2.1.4	Table 1(a), Item 15	рF
7	Unwanted response	R _P /R or IZ _P I/R	Para. 9.2.1.5	Table 1(a), Item 17	-
8	Insulation Resistance	Ri	Para. 9.2.1.6	500 Min.	МΩ



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TABLE 3 - ELECTRICAL MEASUREMENTS AT HIGH AND LOW TEMPERATURES

No.	Characteristics	Symbol	ESA/SCC 3501 Test Method	Limits	Unit
9	Frequency variation with Temperature over Top	Δ f (ΔT, P _o)	Para. 9.2.1.2	Table 1(a) Item 8	10-6
10	Resistance variation with Temperature over Top	$\frac{\Delta R}{R} (\Delta T, P_0)$	Para. 9.2.1.2	Table 1(a) Item 9	%

FIGURE 4 - CIRCUITS FOR ELECTRICAL MEASUREMENTS

Not applicable.

TABLE 4 - PARAMETER DRIFT VALUES

No.	Characteristics	Symbol	Spec. and/or Test Method	Test Conditions	Change Limits (Δ)	Unit
1	Resonance frequency drift	$\frac{\Delta f}{f}$	As per Table 2	As per Table 2	± 2.0	10-6
2	Resonance resistance drift	<u>∆ R</u> R	As per Table 2	As per Table 2	± 10 or (1) ± 1.0	% Ω

NOTES 1. Whichever is the highest value.

TABLE 5 - CONDITIONS FOR BURN-IN AND LIFE TEST

No.	Characteristics	Symbol	Condition	Unit
1	Ambient Temperature	T _{amb}	+85 ±5	°C

FIGURE 5 - ELECTRICAL CIRCUIT FOR BURN-IN AND LIFE TEST

Not applicable.



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4.8 <u>ENVIRONMENTAL AND ENDURANCE TESTS (CHARTS IV AND V OF ESA/SCC GENERIC SPECIFICATION NO. 3501)</u>

4.8.1 Measurements and Inspections on Completion of Environmental Tests

The parameters to be measured and inspections to be performed on completion of environmental tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at $T_{amb} = T_0 \pm 2$ °C.

4.8.2 Measurements and Inspections at Intermediate Points and on Completion of Endurance Tests

The parameters to be measured and inspections to be performed at intermediate points and on completion of endurance tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at $T_{amb} = T_0 \pm 2$ °C.

4.8.3 Conditions for Operating Life Test (Part of Endurance Testing)

The requirements for the operating life test are specified in Section 9 of ESA/SCC Generic Specification No. 3501. The test shall be performed as a high temperature storage test and the temperature to be applied shall be the maximum operating temperature specified in the individual Tables 1(a) given in this specification.



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TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING

r		·····						
	ESA/SCC GENERIC S	SPEC. NO. 3501	MEASUREMENTS A	AND INSPECTIONS		LIMITS		
NO.	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS	SYMBOL	Min.	Max.	UNIT
01	Electrical Measurements at Reference Temperature	Para. 9.2.4	Electrical Measurements	Table 2		Tab	le 1(a) 	
02	Shock	Para. 9.3	Initial Measurements Resonance Frequency Resonance Resistance Final Measurements Resonance Frequency Drift Resonance Resistance Drift	Table 2 Item 1 Table 2 Item 2 Table 2 Item 1	f R <u>Δf</u> f ΔR R ΔR		2 Item 1 2 Item 2 +1.0 +10 +1.0	10 ⁻⁶ %
03	Vibration	Para. 9.4	Initial Measurements Resonance Frequency Resonance Resistance Final Measurements Resonance Frequency Drift Resonance Resistance Drift	Table 2 Item 1 Table 2 Item 2 Table 2 Item 1	f R <u>Δf</u> f <u>ΔR</u> R ΔR		2 Item 1 2 Item 2 +1.0 +10 +1.0	10-6 % Ω
04	Seal Test	Para. 9.5	Fine Leak Gross Leak	Para. 9.5.1 Para. 9.5.2		Para	. 9.5.1 . 9.5.2	54
05	Permanence of Marking	Para. 9.8	Final Measurements Visual Examination	No corrosion or obliteration of marking		-	-	-
06	External Visual Inspection		Final Measurements Visual Inspection	ESA/SCC No. 20500	-	_	-	_
07	Solderability	Para. 9.13	-	_	-		_	

- 1. The tests in this table refer to either Chart IV or V, and shall be used as applicable.
- 2. Whichever is the highest value.



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TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING (Cont.)

	ESA/SCC GENERIC S	SPEC. NO. 3501	MEASUREMENTS A	ND INSPECTIONS		LIMITS		
NO.	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS	SYMBOL	Min.	Max.	UNIT
	Climatic Sequence	Para. 9.14					 	
08	Dry Heat	Para. 9.14.1	Initial Measurements					
			Resonance Frequency Resonance Resistance Final Measurements	Table 2 Item 2	f R		2 Item 1 2 Item 2	
			Resonance Frequency Drift		<u>∆ f</u> f	-2.0	+2.0	10-6
			Resonance Resistance Drift	Table 2 Item 2	<u>Δ R</u> R	-10 or (2)	+10	%
09	Cold	Para. 9.14.3	Initial Measurements		ΔR	-1.0	+1.0	Ω
			Resonance Frequency Resonance Resistance Final Measurements	Table 2 Item 2	f R	Para. Final Me	9.14.1.3 asurements	
			Resonance Frequency Drift		<u>∆ f</u> f	-2.0	+ 2.0	10 ⁻⁶
			Resonance Resistance Drift	Table 2 Item 2	ΔR R	-10 or (2)	+10	%
10	Damp Heat (Acclerated)	Para. 9.14,4	Initial Measurements		ΔR	- 1.0	+1.0	Ω
	Remaining Cycles	1 drai 0.14.4	Resonance Frequency Resonance Resistance Final Measurements	Table 2 Item 1 Table 2 Item 2	f R		I 9.14.3.2 asurements	
			Resonance Frequency Drift	Table 2 Item 1	<u>Δ f</u> f	-2.0	+ 2.0	10-6
			Resonance Resistance Drift	Table 2 Item 2	<u>Δ R</u> R	- 10 or (2)	+10	%
			Insulation Resistance	Table 2 Item 8	ΔR Ri	-1.0 500	+ 1.0 -	Ω M Ω
11	Rapid Change of Temperature	Para. 9.15	Initial Measurements Resonance Frequency Resonance Resistance Final Measurements	Table 2 Item 1	f R	Para. 9 Final Mea	9.14.4.2 asurements	
			Resonance Frequency Drift	Table 2 Item 1	$\frac{\Delta f}{f}$	-2.0	+ 2.0	10-6
			Resonance Resistance Drift	Table 2 Item 2	ΔR R	-10 or (2)	+10	%
10	Debasta				ΔR	- 1.0	+1.0	Ω
12	Robustness of Terminations		Tensile Strength Visual Examination Bending	Gen. 3501 Para. 9.16.1 No visible damage Gen. 3501				
			Visual Examination	Para. 9.16.2 No visible damage				

NOTES

- 1. The tests in this table refer to either Chart IV or V, and shall be used as applicable.
- 2. Whichever is the highest value.



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TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING (Cont.)

NO.	ESA/SCC GENERIC S	SPEC. NO. 3501	MEASUREMENTS AND IN	ISPECTIONS		LIMITS		
110.	ENVIRONMENTAL AND ENDURANCE TESTS (1) TEST METHOD AND CONDITIONS		IDENTIFICATION	CONDITIONS	SYMBOL	Min.	Мах.	UNIT
13	Life Test		Initial Measurements Resonance Frequency Resonance Resistance Intermediate Measurements Resonance Frequency	Table 2 Item 1 Table 2 Item 2 At 500 hours Table 2 Item 1	f R		2 Item 1 2 Item 2	10.6
			Drift Resonance Resistance Drift	Table 2 Item 2	Δ f f Δ R R ΔR	-10 or (2) -1.0	+ 2.0 + 10 + 1.0	10 ⁻⁶ % Ω
			Intermediate Measurements (Chart IV) and Final Measurements (Chart V) Resonance Frequency	:				
			Drift Resonance Resitance Drift	Table 2 Item 1 Table 2 Item 2	<u>Δ f</u> f <u>Δ R</u> R	- 2.5 - 10	+ 2.5	10 ⁻⁶
			Final Measurements (Chart IV)	At 2000 hours	ΔR	or (2) -1.0	+ 1.0	Ω
			Resonance Frequency Drift	Table 2 Item 1	<u>Δ f</u> f	-3.0	+3.0	10-6
			Resonance Resistance Drift	Table 2 Item 2	<u>Δ R</u> R	10 or (2)	+ 10	%
L					ΔR	- 1.0	+1.0	Ω

NOTES

1. The tests in this table refer to either Chart IV or V, and shall be used as applicable.

2. Whichever is the highest value.

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TABLE 1(a) - TYPE VARIANT DETAILED INFORMATION

No. Characteristics Symbol Min. Limits Min. Unit Remarks 1 Resonance Frequency f _L 2.0736 MHz 2 Reference Temperature T _o + 25 °C 3 Overtone Order - Fundamental - 4 Load Capacitance C _L 30 pF 5 Rated Drive Level P _o 0.1 mW 6 Frequency Adjustment Tolerance Δf 10 +10 10-6 At T _o °C 7 Resonance Resistance R _L - 100 Ω Over T _{op} °C 8 Frequency Variation with Temperature over T _{op} Δf Not applicable % From frequency measured at T _o °C 9 Resistance Variation with Drive Level Δf Not applicable % * 11 Frequency Variation with Drive Level Δf Not applicable 10-6 * 12 Resistance Variation with Drive Level Δf Not applicable mH *		1				<u>,</u>	
1 Resonance Frequency f_L 2.0736 MHz 2 Reference Temperature T_O +25 °C 3 Overtone Order - Fundamental 4 Load Capacitance C_L 30 pF 5 Rated Drive Level P_O 0.1 mW 6 Frequency Adjustment Δf 10 +10 10-6 At T_O °C 7 Resonance Resistance R_L - 100 Ω Over T_OP °C 8 Frequency Variation with Temperature over T_OP Resistance Variation with Temperature over T_OP 9 Resistance Variation with Temperature over T_OP -55 +105 °C 10 Operating Temperature Range Δf R Not applicable 10-6 11 Frequency Variation with Drive Level Δf R Not applicable 10-6 12 Resistance Variation with Drive Level Δf R Not applicable mH 14 Motional Capacitance C_1 Not applicable fF 15 Static Capacitance C_2 - 7.0 pF 16 Q Factor Q 100 000 - 17 Ratio of Unwanted: Response Resistance or Response Resistance to Response Resistance or Response Resistance or Response Impedance to Response Resistance or Response Impedance to Response Resistance Re	No.	Characteristics	Symbol		mits	l lais	
2 Reference Temperature To +25 °C 3 Overtone Order - Fundamental Load Capacitance CL 30 pF Rated Drive Level Po 0.1 mW Frequency Adjustment Tolerance Resonance Resistance Resonance Resistance Resonance Resistance Resistance Variation with Temperature over Top Operating Temperature Range Tolerance Tolerance Tolerance Tolerance Resistance Variation with Temperature over Top Resistance Variation with Temperature over Top Not applicable Resistance Variation with Drive Level Resistance Variation with Drive Level Resistance Variation with Drive Level Resistance Variation Resonance Resistance Resistance Variation Resistance Variati		Ondi dotoriotios	Cyrribol	Min.	Max.	Onit	Hemarks
3 Overtone Order 4 Load Capacitance CL 30 pF Rated Drive Level Po 0.1 mW 6 Frequency Adjustment Tolerance RL - 100 Ω Over Top °C Frequency Variation with Temperature over Top PResistance Variation with Temperature over Top 10 Operating Temperature Range 11 Frequency Variation with Drive Level RR Not applicable MH 12 Resistance Variation with Drive Level RR Not applicable RR Not applicable RR Not applicable RR Not applicable FF 13 Motional Inductance L1 Not applicable MH Motional Capacitance C1 Not applicable FF 15 Static Capacitance C2 - 7.0 pF 16 Q Factor Q 100 000 17 Ratio of Unwanted: Response Resistance to Resonance Resistance or Response Resistance Or Response Impedance to Resonance Resistance RP/R Ageing Δf f -2.0 +2.0 10-6 After burn-in and per year	1	Resonance Frequency	fL	2.0	0736	MHz	
4 Load Capacitance	2	Reference Temperature	To	-	- 25	°C	
Frequency Adjustment Tolerance Frequency Adjustment Tolerance Resonance Resistance R	3	Overtone Order	-	Funda	amental		
Frequency Adjustment Tolerance	4	Load Capacitance	C _L		30	pF	
Tolerance	5	Rated Drive Level	Po	().1	mW	
8 Frequency Variation with Temperature over Top 9 Resistance Variation with Temperature over Top 10 Operating Temperature Range 11 Frequency Variation with Drive Level 12 Resistance Variation with Drive Level 13 Motional Inductance 14 Motional Capacitance 15 Static Capacitance 16 Q Factor 17 Ratio of Unwanted: Response Resistance or Response Resistance to Resonance Resistance 18 Ageing A R Not applicable 10-6 Not applicable 10-6 Not applicable 10-6 Not applicable 10-6 In the frequency range: f _L -200kHz f _L +200kHz 12 Resistance Resistance or Response Resistance to Resonance Resistance or Resonance Resistance 18 Ageing A f f -2.0 +2.0 10-6 After burn-in and per year	6		$\frac{\Delta f}{f}$	-10	+10	10-6	At To °C
8 Frequency Variation with Temperature over Top Δf f -50 +50 10-6 From frequency measured at To °C 9 Resistance Variation with Temperature over Top ΔR R Not applicable % 10 Operating Temperature Range Top -55 +105 °C 11 Frequency Variation with Drive Level Δf f Not applicable 10-6 12 Resistance Variation with Drive Level ΔR R Not applicable mH 13 Motional Inductance L₁ Not applicable mH 14 Motional Capacitance C₁ Not applicable fF 15 Static Capacitance C₀ - 7.0 pF 16 Q Factor Q 100 000 - 17 Ratio of Unwanted: Response Resistance or Resonance Resistance or Resonance Resistance or Resonance Resistance or Resonance Resistance 3:1 - In the frequency range: fL -200kHz to fL + 200kHz 18 Ageing Δf f -2.0 +2.0 10-6 After burn-in and per year	7	Resonance Resistance	RL	•	100	Ω	Over Top °C
with Temperature over Top After burn-in and per sequency Not applicable % 10 Operating Temperature Range Top -55 + 105 °C 11 Frequency Variation with Drive Level Δ f f Not applicable 10-6 12 Resistance Variation with Drive Level Δ R R Not applicable % 13 Motional Inductance L₁ Not applicable mH 14 Motional Capacitance C₁ Not applicable fF 15 Static Capacitance C₀ - 7.0 pF 16 Q Factor Q 100 000 - In the frequency range: fL -200kHz to fL -200kHz to fL +200kHz 17 Response Resistance or Resistance or Resonance Resistance or Resonance Resistance IZpl/R 3:1 - In the frequency range: fL -200kHz to fL +200kHz 18 Ageing Δ f f f -2.0 +2.0 10-6 After burn-in and per year 19 Terminal Length In the proper content of the proper co	8	with Temperature	$\frac{\Delta f}{f}$	-50	+50	10-6	From frequency
Range Top 198 F105 C 11 Frequency Variation with Drive Level Δ f f Not applicable 10-6 12 Resistance Variation with Drive Level Δ R R Not applicable % 13 Motional Inductance L1 Not applicable mH 14 Motional Capacitance C1 Not applicable fF 15 Static Capacitance C0 - 7.0 pF 16 Q Factor Q 100 000 - 17 Ratio of Unwanted: Response Resistance or Resonance Resistance or Resonance Resistance or Resonance Resistance Rp/R Or Response Impedance to Resonance Resistance Image: Figure 1.200kHz or Resonance Resistance 18 Ageing Δ f f reminal Length -2.0 +2.0 10-6 After burn-in and per year	9	with Temperature	ΔR R	Not ap	plicable	%	
with Drive Level Resistance Variation with Drive Level Motional Inductance L Not applicable MH Motional Capacitance C Not applicable MH Motional Capacitance C Not applicable MF Static Capacitance C Not applicable MF 15 Static Capacitance C Not applicable MF 16 Q Factor Q 100 000 In the frequency range: f _L -200kHz Response Resistance Or Response Resistance Or Response Impedance to Resonance Resistance Not applicable MF In the frequency range: f _L -200kHz to f Not applicable MF Again Again	10		T _{op}	-55	+ 105	°C	
with Drive Level R Not applicable	11	Frequency Variation with Drive Level	$\frac{\Delta f}{f}$	Not ap	plicable	10-6	
14 Motional Capacitance Co - 7.0 pF 15 Static Capacitance Co - 7.0 pF 16 Q Factor Q 100 000 TResponse Resistance to Resonance Resistance or Resonance Resistance Or Resonance Resistance Or Resonance Resistance 18 Ageing Ageing Ageing Ageing Ageing Ageing MH In the frequency range: f _L -200kHz to f _L + 200kHz After burn-in and per year	12		ΔR R	Not ap	plicable	%	
15 Static Capacitance C ₀ - 7.0 pF 16 Q Factor Q 100 000 - 17 Ratio of Unwanted: Response Resistance to Resonance Resistance or Response Impedance to Resonance Resistance 18 Ageing Δf -2.0 +2.0 10-6 After burn-in and per year	13	Motional Inductance	L ₁	Not ap	plicable	mH	
16 Q Factor 17 Ratio of Unwanted: Response Resistance to Resonance Resistance or Resonance Resistance 18 Ageing 19 Terminal Length	14	Motional Capacitance	C ₁	Not ap	olicable	fF	
17 Ratio of Unwanted: Response Resistance to Resonance Resistance or Response Impedance to Resonance Resistance 18 Ageing	15	Static Capacitance	Co	-	7.0	pF	
Response Resistance to Resonance Resistance or Response Impedance to Resonance Resistance 18 Ageing Ageing Ageing Ageing After burn-in and per year	16	Q Factor	Q	100 000		_	
19 Terminal Length	17	Response Resistance to Resonance Resistance or Response Impedance to		3:1	-		range: f _L -200kHz to
19 Terminal Length	18	Ageing	$\frac{\Delta f}{f}$	-2.0	+2.0	10-6	
	19	Terminal Length	L	Figui	e 2	mm	

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TABLE 1(a) - TYPE VARIANT DETAILED INFORMATION

No.	Characteristics	Symbol	Lir Min.	nits Max.	Unit	Remarks
1	Resonance Frequency	fL	2.0		MHz	
2	Reference Temperature	T _o	+	25	°C	
3	Overtone Order	•	Funda	mental		
4	Load Capacitance	C _L	3	30	pF	
5	Rated Drive Level	Po	C).1	mW	
6	Frequency Adjustment Tolerance	$\frac{\Delta f}{f}$	-10	+10	10-6	At T _o °C
7	Resonance Resistance	RL	-	400	Ω	At To °C
8	Frequency Variation with Temperature over Top	Δf f	-40	+40	10-6	From frequency measured at T _o °C
9	Resistance Variation with Temperature over Top	ΔR R	-10	+10	%	From resistance measured at T _o °C
10	Operating Temperature Range	T _{op}	-20	+60	°C	
11	Frequency Variation with Drive Level	<u>Δ f</u> f	Not ap	plicable	10-6	
12	Resistance Variation with Drive Level	<u>∆ R</u> R	Not ap	olicable	%	
13	Motional Inductance	L ₁	Not app	olicable	mH	
14	Motional Capacitance	C ₁	Not app	olicable	fF	
15	Static Capacitance	Co	Not app	olicable	pF	
16	Q Factor	Q	Not app	olicable	-	
17	Ratio of Unwanted: Response Resistance to Resonance Resistance or Response Impedance to Resonance Resistance	Rp/R IZpI/R	3:1	-		In the frequency range: f _L -200kHz to f _L + 200kHz
	Ageing	$\frac{\Delta f}{f}$	-3.0	+3.0	10-6	After burn-in and per year
19	Terminal Length	L	Figur	e 2	mm	

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TABLE 1(a) - TYPE VARIANT DETAILED INFORMATION

No.	Characteristics	Symbol	Li Min.	mits Max.	Unit	Remarks
1	Resonance Frequency	fL	24	2.4576		
2	Reference Temperature	T _o	 	- 25	MHz °C	
3	Overtone Order			amental		
4	Load Capacitance	CL		20	pF	
5	Rated Drive Level	Po).1	mW	
6	Frequency Adjustment Tolerance	$\frac{\Delta f}{f}$	-10	+10	10-6	At To °C
7	Resonance Resistance	RL	-	500	Ω	At To °C
8	Frequency Variation with Temperature over Top	Δf f	-100	+100	10-6	From frequency measured at T ₀ °C
9	Resistance Variation with Temperature over Top	ΔR R	-20	+20	%	From resistance measured at T ₀ °C
10	Operating Temperature Range	T _{op}	-40	+70	°C	
11	Frequency Variation with Drive Level	$\frac{\Delta f}{f}$	Not ap	plicable	10-6	
12	Resistance Variation with Drive Level	ΔR R	Not ap	plicable	%	
13	Motional Inductance	L ₁	Not ap	plicable	mH	
14	Motional Capacitance	C ₁	Not ap	plicable	fF	
15	Static Capacitance	Co	Not ap	plicable	pF	
16	Q Factor	Q	Not ap	plicable	_	
17	Ratio of Unwanted: Response Resistance to Resonance Resistance or Response Impedance to Resonance Resistance	Rp/R IZpI/R	Not applicable			-
18	Ageing	$\frac{\Delta f}{f}$	-100	+ 100	10-6	Over 6 years
19	Terminal Length	L	Figu	re 2	mm	

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TABLE 1(a) - TYPE VARIANT DETAILED INFORMATION

No.	Characteristics	Symbol	Lir Min.	mits Max.	Unit	Remarks
1	Resonance Frequency	fL	2.	2.304		
2	Reference Temperature	To	+	25	°C	
3	Overtone Order	-	Funda	amental		
4	Load Capacitance	CL		30	pF	
5	Rated Drive Level	Po).1	mW	
6	Frequency Adjustment Tolerance	$\frac{\Delta f}{f}$	-10	+10	10 ⁻⁶	At T _o °C
7	Resonance Resistance	RL	-	500	Ω	At To °C
8	Frequency Variation with Temperature over Top	$\frac{\Delta f}{f}$	-100	+100	10-6	From frequency measured at T ₀ °C
9	Resistance Variation with Temperature over Top	ΔR R	-20	+20	%	From resistance measured at T ₀ °C
10	Operating Temperature Range	T _{op}	-40	+70	°C	
11	Frequency Variation with Drive Level	<u>Δ f</u>	Not ap	plicable	10-6	
12	Resistance Variation with Drive Level	<u>Δ R</u> R	Not ap	plicable	%	
13	Motional Inductance	L ₁	Not ap	plicable	mH	
14	Motional Capacitance	C ₁	Not ap	plicable	fF	
15	Static Capacitance	Co	Not ap	plicable	ρF	
16	Q Factor	Q	Not app	olicable	-	_
17	Ratio of Unwanted: Response Resistance to Resonance Resistance or Response Impedance to Resonance Resistance	Rp/R IZpI/R	Not applicable			
18	Ageing	Δf f	-100	+ 100	10-6	Over 6 years
19	Terminal Length	L	Figu	re 2	mm	

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TABLE 1(a) - TYPE VARIANT DETAILED INFORMATION

No.	Characteristics	Symbol	Lin Min.	nits Max.	Unit	Remarks
1	Resonance Frequency	fL	20.12	20.125984		
2	Reference Temperature	То	+ 55	+ 58	°C	
3	Overtone Order	-	;	5		
4	Load Capacitance	CL	20	35	pF	
5	Rated Drive Level	Po	0	.1	mW	
6	Frequency Adjustment Tolerance	$\frac{\Delta f}{f}$	Not ap	plicable	10-6	
7	Resonance Resistance	RL	-	40	Ω	Over Top °C
8	Frequency Variation with Temperature over Top	Δf f	-2.0	+2.0	10-6	From frequency measured at T ₀ °C
9	Resistance Variation with Temperature over Top	<u>∆R</u> R	Not applicable		%	
10	Operating Temperature Range	T _{op}	+ 53	+ 58	°C	
11	Frequency Variation with Drive Level	$\frac{\Delta f}{f}$	Not app	olicable	10-6	
12	Resistance Variation with Drive Level	ΔR R	Not app	olicable	%	
13	Motional Inductance	L ₁	Not app	licable	mH	
14	Motional Capacitance	C ₁	Not app	licable	fF	
15	Static Capacitance	Co	Not app	licable	pF	
16	Q Factor	Q	400 000	-	-	
17	Ratio of Unwanted: Response Resistance to Resonance Resistance or Response Impedance to Resonance Resistance	Rp/R IZpI/R	Not applicable			-
18	Ageing	<u>Δ f</u> f	Not app	Not applicable		
19	Terminal Length	L	Figur	e 2	mm	·

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TABLE 1(a) - TYPE VARIANT DETAILED INFORMATION

			ή			
No.	Characteristics	Symbol		mits	Unit	Damada
	Onal dotonotios	Cymbor	Min.	Max.	Offic	Remarks
1	Resonance Frequency	fL	1.	1.536		
2	Reference Temperature	To	+	- 25	°C	
3	Overtone Order	-	Funda	amental		
4	Load Capacitance	CL	,	30	pF	
5	Rated Drive Level	Po		1.0	mW	
6	Frequency Adjustment Tolerance	Δf f	-20	+20	10-6	At To °C
7	Resonance Resistance	R_{L}	-	300	Ω	Over Top °C
8	Frequency Variation with Temperature over Top	<u>Δ f</u>	-20	+20	10-6	From frequency measured at T _o °C
9	Resistance Variation with Temperature over Top	ΔR R	Not ap	Not applicable		
10	Operating Temperature Range	T _{op}	0	+80	°C	
11	Frequency Variation with Drive Level	$\frac{\Delta f}{f}$	Not ap	plicable	10-6	
12	Resistance Variation with Drive Level	<u>Δ R</u> R	Not ap	plicable	%	
13	Motional Inductance	L ₁	Not ap	plicable	mH	
14	Motional Capacitance	C ₁	Not ap	plicable	fF	
15	Static Capacitance	Co	-	7.0	pF	
16	Q Factor	Q	Not ap	plicable	-	
17	Ratio of Unwanted: Response Resistance to Resonance Resistance or Response Impedance to Resonance Resistance	Rp/R IZpI/R	2:1	-		In the frequency range: f _L -1.0MHz to f _L +1.0MHz
18	Ageing	<u>Δ f</u> f	-5.0	+5.0	10-6	·
19	Terminal Length	L	Figu	re 2	mm	
		· - ·				i .